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(54) Title: PARAMETER GENERATION APPARATUS, ENCRYPTION SYSTEM, DECRYPTION SYSTEM, ENCRYPTION APPARATUS, DECRYPTION APPARATUS, ENCRYPTION METHOD, DECRYPTION METHOD, AND PROGRAM THEREOF

	سر	110
	Formula storage	uni
Lattice constant GL	2.12	
Decryption time evaluation formula EF	log(T)=0.04N-6.2	
Lattice constant GL	3.5	
Decryption time evaluation formula EF	log(T)=0.08N-4.8	
Lattice constant GL	4.6	
Decryption time evaluation formula EF	log(T)=0.13N-4.4	
Conditional expression ED	6d+2df-1 <q 2<="" td=""><td></td></q>	
Initial security determination formula IF	log(T)=0.2002N-18.884	

(57) Abstract: A parameter generation apparatus for generating parameters causing no decryption error for an NTRU cryptosystem so that an encrypted communication can be carried out between an encryption apparatus and a decryption apparatus in a secure and reliable manner, is comprised of: a provisional parameter generation unit operable to generate a set of provisional parameters that do not cause any decryption errors, based on error condition information that is provided in advance, said error condition information indicating a condition for causing no decryption error; and an output parameter generation unit operable to generate an output parameter that does not cause any decryption errors, using said set of provisional parameters, based on a lattice constant that is calculated from said set of provisional parameters.

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.